Search Notes

Application/Contro	l No. Applican Reexami	t(s)/Patent under nation
09/350,436	JEONG,	CHANG-RAE
Examiner	Art Unit	
Ted M. Wang	2634	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	2/17/2006	TW	
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